CE EMC

TEST REPORT

For

Compact Board

Model: PCM-5893

Trade Name: AAEON

Issued to

AAEON Technology Inc. 5F, No. 135, Lane 235, Pao Chiao Rd., Hsin-Tien City, Taipei, Taiwan, R.O.C.

Issued by



Compliance Certification Services Inc. Hsintien Lab.

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1 TEST RESULT CERTIFICATION

Applicant: AAEON Technology Inc.

5F, No.135, Lane 235, Pao Chiao Rd., Hsin-Tien City,

Date of Issue: January 13, 2006

Taipei, Taiwan, R.O.C.

Manufacturer: AAEON Technology Inc.

5F, No.135, Lane 235, Pao Chiao Rd., Hsin-Tien City,

Taipei, Taiwan, R.O.C.

Equipment Under Test: Compact Board

Trade Name: AAEON

Model: PCM-5893

Detailed EUT Description: See Item 2 of this report

Date of Test: November 25, 2005 ~ January 10, 2006

Applicable Standard	Class/Limit/Criterion	Test Result		
EN 55022:1998 + A1: 2000+A2: 2003	Class A	No non-compliance noted		
EN 61000-3-2: 2000	Class D	No non-compliance noted		
EN 61000-3-3: 1995 + A1: 2001	Limit	No non-compliance noted		
EN 55024:1998 + A1: 2001 + A2: 2003, includi	ng			
IEC 61000-4-2: 1995 +A1: 1998 +A2: 2000	Criterion B	No non-compliance noted		
IEC 61000-4-3: 2002 + A1: 2002	Criterion A	No non-compliance noted		
IEC 61000-4-4: 1995 + A1: 2000 + A2: 2001	Criterion B	No non-compliance noted		
IEC 61000-4-5: 1995 +A1: 2000	Criterion B	No non-compliance noted		
IEC 61000-4-6: 1996 +A1: 2000	Criterion A	No non-compliance noted		
IEC 61000-4-8: 1993 +A1: 2000	Criterion A	N/A		
IEC 61000-4-11: 1994 +A1: 2000	Criterion B/C/C	No non-compliance noted		
Deviation from Applicable Standard				
None				

The above equipment was tested by Compliance Certification Services Inc. for compliance with the requirements set forth in the EMC Directive 89/336/EMC and the technical standards mentioned above. The results of testing in this report apply only to the product/system, which was tested. Other similar equipment will not necessarily produce the same results due to production tolerance and measurement uncertainties.

Approved by: Reviewed by:

Rick Yeo

Manager of Hsintien Laboratory

Compliance Certification Services Inc.

Vince Chiang

Assistant Manager of Hsintien Laboratory

Compliance Certification Services Inc.

2 EUT DESCRIPTION

Product	Compact Board		
Trade Name	AAEON		
Model	PCM-5893		
Housing Type	N/A		
EUT Power Rating	3.3 VDC/ ± 5 VDC/ ± 12 VDC from Host PC Power Supply		
AC Power During Test	230VAC / 50 Hz to Host PC Power Supply		
Power Supply Manufacturer	Enhance		
Power Supply Model Number	P1G-6300P		
AC Power Cord Type	Unshielded, 1.8m (Detachable) to Host PC Power Supply		
OSC/Clock Frequencies	16MHz; 14.318MHz; 24.576MHz; 25MHz; 32.768kHz		

I/O PORT OF EUT

I/O PORT TYPE	Q'TY	TESTED WITH
1). PIO Port	1	1
2). SIO Port	4	4
3). PS/2 Keyboard Port	1	1
4). PS/2 Mouse Port	1	1
5). Video out Port (VGA)	1	1
6). Audio in Port	2	2
7). LAN Port	1	1
8). USB 2.0 Port	4	4

Note: Client consigns only one model sample (Model Number is PCM-5893) to test.

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3 TEST METHODOLOGY

3.1 EUT SYSTEM OPERATION

- 1. Windows XP boots system.
- 2. Run Emctest.exe to activate all peripherals and display "H" pattern on monitor screen.

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- 3. Run Winemc.exe then select (E:/, F:/, G:/, H:/) to test USB 2.0 ports.
- 4. Run Winemc.exe and choose media player to play music.
- 5. Press the start menu, select executive and type ping 192.168.0.2 –t (EUT), ping 192.168.0.1 –t (Server Notebook).

Note: Test program is self-repeating throughout the test.

3.2 DECISION OF FINAL TEST MODE

1. The following test mode(s) were scanned during the preliminary test:

Mode:

1. NORMAL MODE

2. After the preliminary scan, the following test mode(s) was found to produce the highest emission level.

Conduction: Mode 1 **Radiation:** Mode 1

Then, the EUT configuration and cable configuration of the above highest emission mode was chosen for all final test items.

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4 SETUP OF EQUIPMENT UNDER TEST

Setup Diagram

See test photographs attached in Appendix I for the actual connections between EUT and support equipment.

Support Equipment

Host PC Devices:

No	Equipment	Model #	Serial No.	Trade Name
1	CPU (400MHz)	GX-MMX	N/A	Geode
2	Memory (256MB)	DDR333	HY5DU56822BT-D43	Hynix
3	Power Supply	P1G-6300P, 300Watts	N/A	Enhance
4	HDD (40GB)	D540X-4D, 5400rpm	N/A	Maxtor

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Peripherals Devices:

No	Equipment	Model	Serial No.	FCC/ BSMI ID	Trade Name	Data Cable	Power Cord
1	USB 2.0 HDD	F12-U	N/A	BSMI ID: 4912A002	TeraSys	Shielded, 1.8m	N/A
2	USB 2.0 HDD	F12-U	N/A	BSMI ID: 4912A002	TeraSys	Shielded, 1.8m	N/A
3	Player	RQ-L317	N/A	N/A	PANASONIC	Unshielded, 1.8m	N/A
4	PS/2 Keyboard	SK-8110	N/A	BSMI: T3A002 DoC	DELL	Shielded, 1.8m	N/A
5	PS/2 Mouse	M071KC	443029438	BSMI: R41108 DoC	DELL	Shielded, 1.8m	N/A
6	Ear / Mic	MSB301	N/A	N/A	e-Sense	Unshielded, 1.8m	N/A
7	USB 2.0 HDD	F12-U	N/A	BSMI ID: 4912A002	TeraSys	Shielded, 1.8m	N/A
8	USB 2.0 HDD	F12-U	N/A	BSMI ID: 4912A002	TeraSys	Shielded, 1.8m	N/A
9	Modem	5JEG4033MKO	N/A	5RJTAI-35500-M5-E	TOP- SOLUTION	Shielded, 1.8m	Unshielded, 1.8m
10	Modem	5JEG4033MKO	N/A	5RJTAI-35500-M5-E	TOP- SOLUTION	Shielded, 1.8m	Unshielded, 1.8m
11	Modem	5JEG4033MKO	N/A	5RJTAI-35500-M5-E	TOP- SOLUTION	Shielded, 1.8m	Unshielded, 1.8m
12	Modem	5JEG4033MKO	N/A	5RJTAI-35500-M5-E	TOP- SOLUTION	Shielded, 1.8m	Unshielded, 1.8m
13	Monitor	710V	GS17H9NXA05858E	BSMI: R33475 DoC	SAMSUNG	Shielded, 1.8m with two cores	Unshielded, 1.8m
14	Printer	C60	DR3K039417	BSMI ID: 3902E006	EPSON	Shielded, 1.8 m	Unshielded, 1.8m
15	Server Notebook	M285	RD49R-7YTJR- B3C4K-G2JQX- DD3CG	DoC BSMI: R31259	LEO	Unshielded, 20m	Unshielded, 1.8m

Note: All the above equipment/cables were placed in worse case positions to maximize emission signals during emission test. Grounding: Grounding was in accordance with the manufacturer's requirements and conditions for the intended use.

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5 FACILITIES AND ACCREDITATIONS

5.1 FACILITIES

All measurement facilities used to collect the measurement data are located at CCS Taiwan Hsintien Lab at No. 165, Chunghsen Road, Hsintien City, Taipei Hsien, Taiwan.

The measurement facilities are constructed in conformance with the requirements of CISPR 16-1, ANSI C63.4 and other equivalent standards.

5.2 LABORATORY ACCREDITATIONS AND LISTINGS

The test facilities used to perform Electromagnetic compatibility tests are registered or accredited by the organizations listed in the following table which includes the recognized scope specifically.

Country	Agency	Scope of Accreditation	Logo
USA	A2LA	CFR 47, FCC Part 15/18 using ANSI 63.4; AS/NZS 3548; VCCI V3; CNS 13438; CNS 13439; CNS 13783; CNS 14115; CISPR 11/EN 55011; CISPR 14-1/EN 55014-1; CISPR 15/EN 55015; CISPR 22/EN 55022; EN 50081-1/EN 61000-6-3; EN 50082-1/EN 61000-6-4; IEC/EN 61000-4-2, IEC/EN 61000-4-3, IEC/EN 61000-4-4, IEC/EN 61000-4-5, IEC/EN 61000-3-2, IEC/EN 61000-3-3; CISPR 24/EN 55024; CISPR 14-2/EN 55014-2; EN 50081-2/EN 61000-6-1; EN 50082-2/EN 61000-6-2.	ACCREDITED
USA	FCC	3/10 meter Open Area Test Sites to perform FCC Part 15/18 measurements	F © 250366
Japan	VCCI	3/10 meter Open Area Test Sites and Line Conducted Test Room to perform conducted/radiated measurements	VCCI R-1434/1630~4 C-1511/1882
Norway	NEMKO	EN 50081-1/2, EN 50082-1/2, IEC 61000-6-1/2/3/4, EN 50091-2, EN 50130-4, EN 55011, EN 55013, EN 55014-1/2, EN 55015, EN 55022, EN 55024, EN 61000-3-2/3, EN 61326-1, IEC 61000-4-2/3/4/5/6/8/11, Cispr 16-1/2/3/4	ELA 103
Taiwan	CNLA	47 CFR FCC Part 15 Subpart B, EN 61000-3-2, EN 61000-3-3, CNS 13439, CNS 13783-1, CNS 13438, AS/NZS 3548, VCCI, CNS 13022-1/2/3, EN 55022, EN 55013, EN 55014-1, EN 61000-4-2/3/4/5/6/8/11, ENV 50204, ENV 50141, ENV 50142	1108 ILAC MRA
Taiwan	BSMI	CNS 13438, CNS 13783-1, CNS 13439	SL2-IN-E-0005 SL2-A1-E-0005 SL2-R1-E-0005 SL2-R2-E-0005
Canada	Industry Canada	RSS212, Issue 1	Canada IC 5742

Note: No part of this report may be used to claim or imply product endorsement by CNLA, A2LA or other government agency.

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6 INSTRUMENT AND CALIBRATION

6.1 MEASURING INSTRUMENT CALIBRATION

The measuring equipment utilized to perform the tests documented in this report has been calibrated once a year or in accordance with the manufacturer's recommendations, and is traceable to recognized national standards.

6.2 TEST AND MEASUREMENT EQUIPMENT

The following list contains measurement equipment used for testing. The equipment conforms to the requirement of CISPR 16-1, ANSI C63.2 and. other required standards.

Date of Issue: January 13, 2006

Calibration of all test and measurement, including any accessories that may effect such calibration, is checked frequently to ensure the accuracy. Adjustments are made and correction factors are applied in accordance with the instructions contained in the respective manual.

Equipment Used for Emission Measurement

Open Area Test Site # I					
EQUIPMENT	MFR	MODEL	SERIAL NUMBER	CAL. DUE	
SITE NSA	CCS	I Site	N/A	10/14/2006	
MEASURE RECEIVER	SCHAFFNER	SCR3501	338	06/27/2006	
SPECTRUM ANALYZER	ADVANTEST	R3132	120900008	No Calibration Required	
ANTENNA	SCHAFFNER	CBL 6112B	2809	09/23/2006	
AMPLIFIER	SCHAFFNER	CPA9231A	3626	10/08/2006	
CABLE	BELDEN	9913	N-TYPE #I2	02/18/2006	
ATTENUATOR	MCL	UNAT-6	AT06-3	10/08/2006	
THERMO- HYGRO METER	TFA	N/A	NO.2	11/02/2006	
DECOUPLING NETWORK	FCC	F-201-DCN-5-6MM	22、24	08/24/2006	

Note: The measurement uncertainty is less than +/- 3.36dB, which is evaluated as per the NAMAS NIS 81 and CISPR/A/291/CDV.

Conducted Emission Test Site # B					
EQUIPMENT	MFR	MODEL	SERIAL NUMBER	CAL. DUE	
TEST RECEIVER	R&S	ESHS10	843743/015	03/31/2006	
LISN (EUT)	EMCO	3825/2	9106-1810	01/16/2006	
LISN	EMCO	3825/2	1382	01/16/2006	
BNC CABLE	MIYAZAKI	5D-FB	BNC B1	07/14/2006	
Pulse Limiter	R&S	ESH3-Z2	100374	08/25/2006	
THERMO- HYGRO METER	ТОР	HA-202	9303-3	03/02/2006	
4-Wire ISN	R&S	ENY41	100006	07/06/2006	
2-Wire ISN	R&S	ENY22	100020	07/06/2006	

Note: The measurement uncertainty is less than +/- 2.83dB, which is evaluated as per the NAMAS NIS 81 and CISPR/A/291/CDV.

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Power Harmonic & Voltage Fluctuation/Flicker Test Site (EN 61000-3-2&-3-3)					
Manufacturer/Type	Cal. Due				
Schaffner / Signal Conditioning Unit	CCN 1000-1	72122	12/01/2006		
Schaffner / 5KVA AC Power Source	NSG 1007	55131	No Calibration Required		

Equipment Used for Immunity Measurement

ESD Test Site (EN 61000-4-2)						
Manufacturer/Type	Cal. Due					
Schaffner / ESD Simulator	NSG 438	129	04/20/2006			
Sato / Aneroid Barometer	7610-20	89090	08/29/2006			
TOP / Thermo-Hygro meter	HA-202	9303-1	03/02/2006			

Radiated Electromagnetic Field Immunity Test Site (EN 61000-4-3)					
Manufacturer/Type	Model No.	Serial No.	Cal. Due		
Calibration of Field	Chamber#RS	RS3H-7 / RS3V-7	07/01/2006		
Agilent / Signal Generator	E4421B	MY43350597	05/16/2006		
AR / Electric Field Probe	FP6001	305650	02/03/2006		
Boonton / RF Voltmeter	9200B	328001AE	02/23/2006		
BNC / Function Generator	625A	25451	02/17/2006		
AR / Amplifier	100W1000M1	17564	No Calibration Required		
Werlatone Inc. / Direction Coupler	C2630	4121	No Calibration Required		
Frankonia / Broadband Antenna	BTA-M	030001M	No Calibration Required		
TOP / Thermo-Hygro meter	HA-202	9303-2	03/02/2006		

Fast Transients/Burst Test Site (EN 61000-4-4)						
Manufacturer/Type Model No. Serial No. Cal. Due						
Schaffner / EFT Generator	BEST EMC V2.3	200031A024SC	11/07/2006			
Schaffner / Capacitive Clamp	N/A	N/A	No Calibration Required			

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Surge Immunity Test Site (EN 61000-4-5)							
Manufacturer/Type Model No. Serial No. Cal. Due							
Schaffner / Surger Generator	BEST EMC V2.3	200031A024SC	11/07/2006				
Schaffner / Signal and Data Lines Coupling Network	CDN118	19328	No Calibration Required				

CS test (EN 61000-4-6)							
Manufacturer/Type	Model No.	Serial No.	Cal. Due				
Schaffner / RF Generator	NSG 2070-1	1061	08/03/2006				
Schaffner / CDN	CDN M316	19600	08/02/2006				
Schaffner / CDN	CDN M216	19294	08/02/2006				
FCC / CDN	FCC-801-M3-16A	99122	08/02/2006				
Schaffner / EM Clamp	KEMZ 801	19227	02/23/2006				
Schaffner / CDN	CDN T002	15881	01/13/2006				
FCC / CDN	FCC-801-T8-RJ45	04025	06/23/2006				
Schaffner / Attenuator	INA2070-1	2061	No Calibration Required				
FCC / CDN	FCC-801-T4-RJ45	04031	08/02/2006				

Power Frequency Magnetic Field Immunity test (EN 61000-4-8)							
Manufacturer/Type	Model No.	Serial No.	Cal. Due				
Schaffner / Induction Coil Interface	INA 21141	6009	No Calibration Required				
Schaffner / 5KVA AC Power Source	NSG 1007	55131	No Calibration Required				
CHY/ TRMS Clamp Meter	932C	2K0900285	10/16/2006				
Sypris / Magnetic Field Meter	4080	0247	01/19/2006				

Voltage Dips/Short Interruption and Voltage Variation Immunity test (EN 61000-4-11)							
Manufacturer/Type Model No. Serial No. Cal. Due							
Schaffner / Dips/Interruption/Variations Tester	BEST EMC V2.3	200031A024SC	11/07/2006				
Protronix / Digital Power Meter	1201	201091	08/24/2006				

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7 LINE CONDUCTED & RADIATED EMISSION TEST

7.1 LIMIT

Maximum permissible level of Line Conducted Emission

FREQUENCY	Class A	(dBuV)	Class B (dBuV)		
(MHz)	Quasi-peak	Average	Quasi-peak	Average	
0.15 - 0.5	79	66	66 - 56	56 - 46	
0.50 - 5.0	73	60	56	46	
5.0 - 30.0	73	60	60	50	

Note: The lower limit shall apply at the transition frequency.

<u>Maximum permissible level of Common Mode Conducted Emission</u> (<u>Telecommunication Ports</u>)

CLASS A

FREQUENCY	Voltage Limit (dBuV)		Current Limit (dBuA)		
(MHz)	Quasi-peak	Average	Quasi-peak	Average	
0.15 - 0.5	97 – 87	84 - 74	53 – 43	40 – 30	
0.5 - 30.0	87	74	43	30	

CLASS B

FREQUENCY	Voltage Limit (dBuV)		Current Limit (dBuA)		
(MHz)	Quasi-peak Average		Quasi-peak	Average	
0.15 - 0.5	84 - 74	74 - 64	40 – 30	30 – 20	
0.5 - 30.0	74	64	30	20	

Note: The lower limit shall apply at the transition frequency.

Maximum permissible level of Radiated Emission measured at 10 meter

FREQUENCY	Class A (dBuV/m)	Class B (dBuV/m) Quasi-peak		
(MHz)	Quasi-peak			
30 – 230	40	30		
230 - 1000	47	37		

Note: The lower limit shall apply at the transition frequency.

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7.2 TEST PROCEDURE OF LINE CONDUCTED EMISSION

Procedure of Preliminary Test

• The EUT was set up as per the test configuration to simulate typical usage per the user's manual. When the EUT is a tabletop system, a wooden table with a height of 0.8 meters is used and is placed on the ground plane as per EN 55022 (see Test Facility for the dimensions of the ground plane used). When the EUT is a floor-standing equipment, it is placed on the ground plane which has a 3-12 mm non-conductive covering to insulate the EUT from the ground plane.

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- Support equipment, if needed, was placed as per EN 55022.
- All I/O cables were positioned to simulate typical actual usage as per EN 55022.
- The test system with EUT received AC power, 230V/50Hz, through a Line Impedance Stabilization Network (LISN), which supplied power source and was grounded to the ground plane.
- All support equipment received power from a second LISN.
- The EUT test program was started. Emissions were measured on each current carrying line of the EUT using an EMI Test Receiver connected to the LISN powering the EUT.
- The Receiver scanned from 150kHz to 30MHz for emissions in each of the test modes.
- During the above scans, the emissions were maximized by cable manipulation.
- The test mode(s) described in Item 3.2 were scanned during the preliminary test.
- After the preliminary scan, we found the test mode described in Item 3.2 producing the highest emission level.
- The EUT configuration and cable configuration of the above highest emission level were recorded for reference of the final test.

Procedure of Final Test

- EUT and support equipment were set up on the test bench as per the configuration with highest emission level in the preliminary test.
- A scan was taken on both power lines, Line 1 and Line 2, recording at least the six highest emissions. Emission frequency and amplitude were recorded into a computer in which correction factors were used to calculate the emission level and compare reading to the applicable limit. If EUT emission level was less –2dB to the Average limit in Q.P. mode, then the emission signal was re-checked using an Average detector.
- The test data of the worst-case condition(s) was recorded.

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Data Sample:

Freq. MHz	Read Level dBuV	Factor dB	Level dBuV	Limit dBuV	Over Limit dB	Reading Type (P/Q/A)	Line (L1/L2)
x.xx	42.95	0.55	43.50	73	-29.50	Q	L1

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Freq. = Emission frequency in MHz

Read Level = Uncorrected Analyzer/Receiver reading Factor = Insertion loss of LISN + Cable Loss

Level = Read Level + Factor
Limit = Limit stated in standard
Over Limit = Reading in reference to limit

P = Peak Reading Q = Quasi-peak Reading A = Average Reading

L1 = Hot side L2 = Neutral side

Calculation Formula

Over Limit (dB) = Level (dBuV) – Limit (dBuV)

7.3 TEST PROCEDURE OF COMMON MODE CONDUCTED EMISSION FOR TELECOMMUNICATION PORT

- Selecting ISN for unscreened cable or a current probe for screened cable to take measurement.
- The port of the EUT was connected to the remote side support equipment through the ISN/Current Probe and communication in normal condition.
- Making a overall range scan by using the test receiver controlled by controller and record at least six highest emissions for showing in the test report.
- Emission frequency and amplitude were recorded into a computer in which correction factors were used to calculate the emission level and compare reading to the applicable limit.
- In case of measuring on the screened cable, the current limit shall be applied, otherwise the voltage limit should be applied.
- The following test mode(s) were scanned during the preliminary test:

Mode(s):

- 1 10 Mbps
- 2 100Mbps
- After the preliminary scan, we found the following test mode(s) producing the highest emission level and test data of the worst case was recorded.

Mode: 2

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Data Sample:

Freq. MHz	Read Level dBuV	Factor dB	Level dBuV	Limit dBuV	Over Limit dB	Reading Type (P/Q/A)
x.xx	62.95	0.55	63.50	87	-23.50	Q

Date of Issue: January 13, 2006

Freq. = Emission frequency in MHz

Read Level = Uncorrected Analyzer/Receiver reading Factor = Insertion loss of ISN + Cable Loss

Level = Read Level + Factor
Limit = Limit stated in standard
Over Limit = Reading in reference to limit

P = Peak Reading

Q = Quasi-peak Reading A = Average Reading

Calculation Formula

Over Limit (dB) = Level (dBuV) – Limit (dBuV)

7.4 TEST PROCEDURE OF RADIATED EMISSION

Procedure of Preliminary Test

- The equipment was set up as per the test configuration to simulate typical usage per the user's manual. When the EUT is a tabletop system, a wooden turntable with a height of 0.8 meters is used which is placed on the ground plane. When the EUT is a floor-standing equipment, it is placed on the ground plane which has a 3-12 mm non-conductive covering to insulate the EUT from the ground plane.
 - Support equipment, if needed, was placed as per EN 55022.
 - All I/O cables were positioned to simulate typical usage as per EN 55022.
 - The EUT received AC power source, 230V/50Hz, from the outlet socket under the turntable. All support equipment received power from another socket under the turntable.
 - Mains cables, telephone lines or other connections to auxiliary equipment located outside the test are shall drape to the floor, be fitted with ferrite clamps or ferrite tubes placed on the floor at the point where the cable reaches the floor and then routed to the place where they leave the turntable. No. extension cords shall be used to mains receptacle.
 - The antenna was placed at 10 meter away from the EUT as stated in EN 55022. The antenna connected to the Spectrum Analyzer via a cable and at times a pre-amplifier would be used.
 - The Analyzer / Receiver quickly scanned from 30MHz to 1000MHz. The EUT test program was started. Emissions were scanned and measured rotating the EUT to 360 degrees and positioning the antenna 1 to 4 meters above the ground plane, in both the vertical and the horizontal polarization, to maximize the emission reading level.

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- The test mode(s) described in Item 3.2 were scanned during the preliminary test:
- After the preliminary scan, we found the test mode described in Item 3.2 producing the highest emission level.
- The EUT and cable configuration, antenna position, polarization and turntable position of the above highest emission level were recorded for the final test.

Procedure of Final Test

- EUT and support equipment were set up on the turntable as per the configuration with highest emission level in the preliminary test.
- The Analyzer / Receiver scanned from 30MHz to 1000MHz. Emissions were scanned and measured rotating the EUT to 360 degrees, varying cable placement and positioning the antenna 1 to 4 meters above the ground plane, in both the vertical and the horizontal polarization, to maximize the emission reading level.
- Recorded at least the six highest emissions. Emission frequency, amplitude, antenna position, polarization and turntable position were recorded into a computer in which correction factors were used to calculate the emission level and compare reading to the applicable limit and only Q.P. reading is presented.

Data Sample:

Freq. MHz	Read Level dBuV	Factor dB/m	Level dBuV/m	Limit dBuV/m	Over Limit dB	Reading Type (P/Q/A)	Pol. (H/V)
x.xx	14.0	12.2	26.2	40	-13.8	Q	Н

Freq. = Emission frequency in MHz

Reading = Uncorrected Analyzer/Receiver reading

Factor = Antenna Factor + Cable Loss + Attenuator (3/6/10dB) - Amplifier Gain

= Uncorrected Analyzer/Receiver reading + Factor Amptd

Limit = Limit stated in standard Margin = Reading in reference to limit

P = Peak Reading

Q = Quasi-peak Reading = Average Reading Α

Η = Antenna Polarization: Horizontal = Antenna Polarization: Vertical

Calculation Formula

Margin (dB) = Amptd (dBuV/m) – Limit (dBuV/m)

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7.5 TEST RESULTS

Line Conducted Emission

Model: PCM-5893 **Test Mode:** Mode 1

Temperature: 21°C **Humidity:** 68% RH

Test Results: Passed Tested by: MATT HSU

(The chart below shows the highest readings taken from the final data)

Six Highest Conducted Emission Readings							
Fre	quency Ran	ge Investiga	ated	150 kHz to 30 MHz			
Freq (MHz)	Read Level (dBuV)	Factor (dB)	Level (dBuV)	Limit Line (dBuV)	Over Limit (dB)	Reading Type (P/Q/A)	Line (L1/L2)
0.213	37.71	9.95	47.66	79.00	-31.34	P	L1
0.315	40.56	9.93	50.49	79.00	-28.51	P	L1
0.419	42.80	9.94	52.74	79.00	-26.26	P	L1
0.524	30.35	9.97	40.32	73.00	-32.68	P	L1
0.150	55.73	10.01	65.74	79.00	-13.26	P	L2
0.408	56.18	9.93	66.11	79.00	-12.89	P	L2

NOTE: The emission level was or more than 2dB below the Average limit, so no re-check anymore.

Common Mode Conducted Emission

	Six Highest Conducted Emission Readings					
Fre	equency Ran	ge Investigat	ed	150	kHz to 30 MF	łz
Freq (MHz)	Read Level (dBuV)	Factor (dB)	Level (dBuV)	Limit Line (dBuV)	Over Limit (dB)	Reading Type (P/Q/A)
2.237	51.50	20.07	71.57	87.00	-15.43	P
12.188	46.26	20.15	66.41	87.00	-20.59	P
13.408	46.39	20.14	66.53	87.00	-20.47	P
15.552	48.51	20.14	68.65	87.00	-18.35	P
20.814	48.30	20.16	68.46	87.00	-18.54	P
24.529	42.96	20.19	63.16	87.00	-23.84	P

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Test Mode: Mode 2

Radiated Emission

Model: PCM-5893 Test Mode: Mode 1

Temperature: 20°C **Humidity:** 70 % RH

Test Results: Passed Tested by: BENSON YANG

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(The chart below shows the highest readings taken from the final data.)

	Six Highest Radiated Emission Readings						
Fre	quency Rai	nge Investig	ated	30 MHz to 1000 MHz at 10m			m
Freq (MHz)	Amptd (dBuV/m)	Margin (dB)	Limit (dBuV/m)	Reading (dBuV)	Factor (dB/m)	Reading Type (P/Q/A)	Pol. (H/V)
66.290	47.00	-15.44	31.56	40.00	-8.44	Q	V
73.210	45.80	-15.13	30.67	40.00	-9.33	Q	V
114.230	38.70	-9.59	29.11	40.00	-10.89	Q	V
125.000	37.50	-9.25	28.25	40.00	-11.75	Q	V
157.490	37.90	-10.91	26.99	40.00	-13.01	Q	V
110.770	37.70	-9.90	27.80	40.00	-12.20	Q	H

NOTE: None.

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8 POWER HARMONICS TEST

Port : AC Power Port

Basic Standard : EN 61000-3-2 (2000)

Limits : \square CLASS A; \overline{V} CLASS D

Teste d by : MATT HSU

Temperature : 19°C **Humidity** : 50%

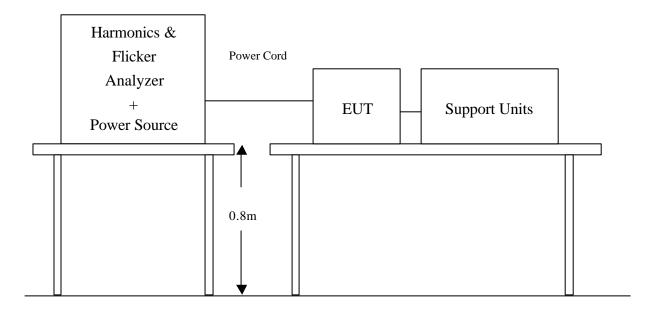
Limit:

Limits for	Limits for Class A equipment				
Harmonics	Max. permissible				
Order	harmonics current				
n	A				
Od	d harmonics				
3	2.30				
5	1.14				
7	0.77				
9	0.40				
11	0.33				
13	0.21				
15<=n<=39	0.15x15/n				
Eve	en harmonics				
2	1.08				
4	0.43				
6	0.30				
8<=n<=40	0.23x8/n				

	Limits for Class D equip	oment
Harmonics Order n	Max. permissible harmonics current per watt mA/W	Max. permissible harmonics current
	Odd Harmonics only	7
3	3.4	2.30
5	1.9	1.14
7	1.0	0.77
9	0.5	0.40
11	0.35	0.33
13	0.30	0.21
15<=n<=39	3.85/n	0.15x15/n

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Block Diagram of Test Setup:



Test Procedure:

- a. The EUT was placed on the top of a wooden table 0.8 meters above the ground and operated to produce the maximum harmonic components under normal operating conditions for each successive harmonic component in turn.
- b. The correspondent test program of test instrument to measure the current harmonics emanated from EUT is chosen. The measure time shall be not less than the time necessary for the EUT to be exercised.

<u>Test Result</u>: (See Appendix II for details)

	☐ FAIL
Note: No function degraded during the tests.	

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9 POWER VOLTAGE FLUCTUATION / FLICKER TEST

Port : AC Power Port

Basic Standard : EN 61000-3-3 (1995 + A1: 2001)

Limits : § of EN 61000-3-3

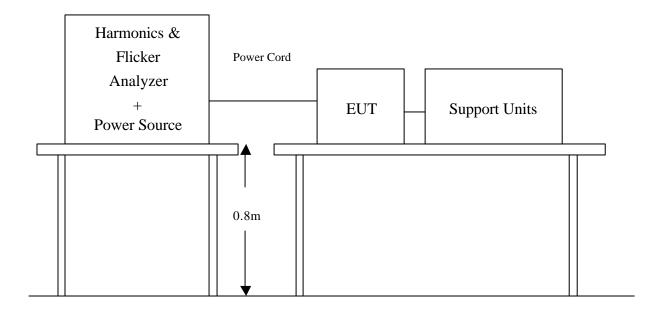
Teste d by : MATT HSU

Temperature : 19°C **Humidity** : 50%

Limit:

TEST ITEM	LIMIT	REMARK
P_{st}	1.0	P_{st} means short-term flicker indicator.
P_{lt}	0.65	P _{lt} means long-term flicker indicator.
T _{dt} (ms)	500	T_{dt} means maximum time that dt exceeds 3.3 %.
d _{max} (%)	4%	d_{max} means maximum relative voltage change.
dc (%)	3.3%	dc means relative steady-state voltage change

Block Diagram of Test Setup:



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Test Procedure:

- The EUT was placed on the top of a wooden table 0.8 meters above the ground and operated to produce the most unfavorable sequence of voltage changes under normal operating conditions.
- During the flick measurement, the measure time shall include that part of whole operation cycle in which the EUT produce the most unfavorable sequence of voltage changes. The observation period for short-term flicker indicator is 10 minutes and the observation period for long-term flicker indicator is 2 hours.

Test Result: (See Appendix II for details)

TEST PARAMETER	MEASUREMENT VALUE	LIMIT	RESULT
P_{st}	0.001	1.0	Pass
P_{lt}	0.001	0.65	Pass
T _{dt} (ms)	0	500	Pass
d _{max} (%)	0	4%	Pass
dc (%)	0	3.3%	Pass

Note: None.

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10 ELECTROSTATIC DISCHARGE (ESD) IMMUNITY TEST

Port : Enclosure

Basic Standard: IEC/EN 61000-4-2

Test Level : $\pm 8 \text{ kV (Air Discharge)}$

± 4 kV (Contact Discharge)

± 4 kV (Indirect Discharge)

Performance Criterion: B (Standard Required)

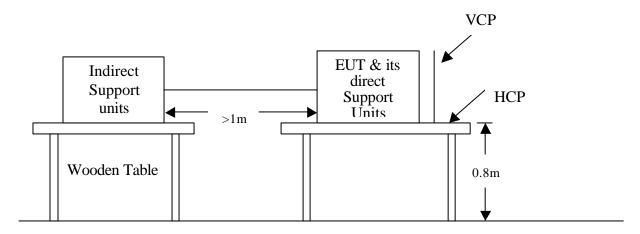
Teste d by : MATT HSU

Temperature : 19°C **Humidity** : 50%

Pressure : 1015mbar

Block Diagram of Test Setup:

(The 470 k ohm resistors are installed per standard requirement.)



Ground Reference Plane

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Test Procedure:

- 1. The EUT was located 0.1 m minimum from all sides of the HCP.
- 2. The indirect support units were located 1 m minimum away from the EUT, but direct support unit was/were located at same location as EUT on the HCP and keep at a distance of 10 cm with EUT.

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- 3. As per the requirement of EN 55024; applying direct contact discharge at the sides other than front of EUT at minimum 50 discharges (25 positive and 25 negative) if applicable, can't be applied direct contact discharge side of EUT then the indirect discharge shall be applied. One of the test points shall be subjected to at least 50 indirect discharge (contact) to the front edge of horizontal coupling plane.
- 4. Other parts of EUT where it is not possible to perform contact discharge then selecting appropriate points of EUT for air discharge, a minimum of 10 single air discharges shall be applied.
- 5. The application of ESD to the contact of open connectors is not required.
- 6. The EUT direct connection units also need to be applied ESD at the port of EUT cable connected.
- 7. Putting a mark on EUT to show tested points. The following test condition was followed during the tests.

Note: As per IEC/EN 61000-4-2, two 470k bleed resistors cable is connected between the EUT and HCP during the test applicable for power ungrounded or battery operating unit only.

The electrostatic discharges were applied as follows:

Amount of discharge	Voltage	Coupling	Result (Pass/Fail)
Mini 10 /Point	± 8 kV	Air Discharge	Pass
Mini 25 /Point	± 4 kV	Contact Discharge	Pass
Mini 25 /Point	$\pm 4 \text{ kV}$	Indirect Discharge HCP (Front)	Pass
Mini 25 /Point	$\pm 4 \text{ kV}$	Indirect Discharge VCP (Right)	Pass
Mini 25 /Point	± 4 kV	Indirect Discharge VCP (Left)	Pass
Mini 25 /Point	$\pm 4 \text{ kV}$	Indirect Discharge VCP (Back)	Pass

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Performance & Result:

	Criterion A:	The apparatus continues to operate as intended. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance.			
	Criterion B:	B: The apparatus continues to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.			
	Criterion C:	Temporary loss of function is allowed, provided the functions self recoverable or can be restored by the operation of controls.			
Oł	oservation:	No function degraded during the tests.			

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11 RADIATED ELECTROMAGNETIC FIELD IMMUNITY TEST

Port : Enclosure

Basic Standard: IEC/EN 61000-4-3

Requirements : 3 V/m / with 80% AM. 1kHz Modulation.

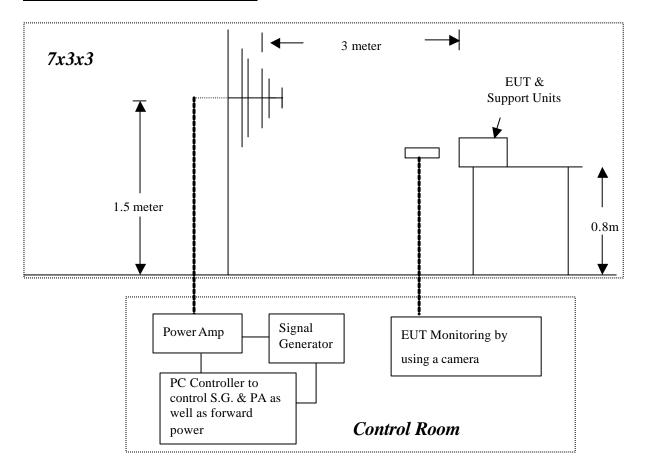
Performance Criterion: A (Standard Required)

Tested by : MATT HSU

Temperature : 19°C **Humidity** : 50%

Pressure : 1015mbar

Block Diagram of Test Setup:



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Test Procedure:

1. The EUT and support units were located at the edge of supporting table keep 3 meter away from transmitting antenna, it just the calibrated square area of field uniformity.

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- 2. Adjusting the cables to be exposed to the electromagnetic filed as possible.
- 3. Performing a Radiated Emission Scan in range of 80 to 1000 MHz prior to do RS test and records the more higher emission frequencies for the reference of RS test, due to antenna effectiveness.
- 4. Adjusting the monitoring camera to monitor the "H" message as clear as possible.
- 5. Setting the testing parameters of RS test software per IEC 61000-4-3.
- 6. Referring to the tested data of step 3 to performing the RS test from 80 to 1000 MHz.
- 7. Recording the test result in following table.
- 8. Changing the EUT to the other side and repeat step 3 to 6, until 4 sides of EUT were verified.

IEC 61000-4-3 Final test conditions:

Test level : 3V/m

Steps : 1 % of fundamental

Dwell Time : 3 sec

Range (MHz)	Field	Modulation	Polarity	Position (°)	Result (Pass/Fail)
80-1000	3V/m	Yes	Н	Front	Pass
80-1000	3V/m	Yes	V	Front	Pass
80-1000	3V/m	Yes	Н	Right	Pass
80-1000	3V/m	Yes	V	Right	Pass
80-1000	3V/m	Yes	Н	Back	Pass
80-1000	3V/m	Yes	V	Back	Pass
80-1000	3V/m	Yes	Н	Left	Pass
80-1000	3V/m	Yes	V	Left	Pass

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Performance & Result:

	Criterion A:	The apparatus continues to operate as intended. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance.			
	Criterion B:	3: The apparatus continues to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.			
	Criterion C:	Temporary loss of function is allowed, provided the functions self recoverable or can be restored by the operation of controls.			
Oł	oservation:	No function degraded during the tests.			

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12 FAST TRANSIENTS/BURST IMMUNITY TEST

Port : AC Power Port and RJ45 Port

Basic Standard: IEC/EN 61000-4-4

Requirements : $\pm 1 \text{ kV for AC Power Port}$

 \pm 0.5kV for RJ45 Port

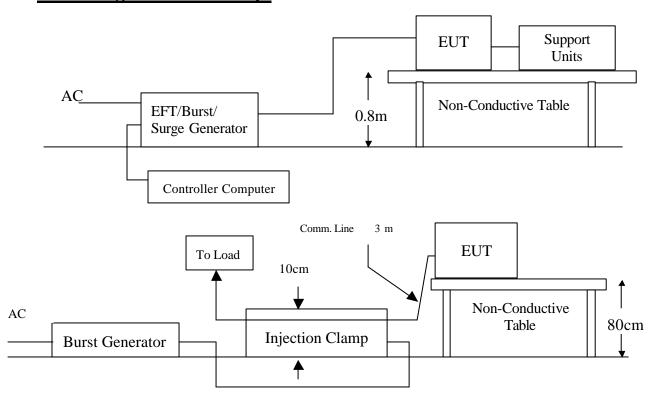
Performance Criteria: B (Standard Required)

Teste d by : MATT HSU

Temperature : 19°C **Humidity** : 50%

Pressure : 1015mbar

Block Diagram of Test Setup:



Test Procedure:

- 1. The EUT and support units were located on a wooden table 0.8 m away from ground reference plane.
- 2. A 1.0 meter long power cord was attached to EUT during the test.
- 3. The length of communication cable between communication port and clamp was keeping within 1 meter.
- 4. Injected test voltage to the EUT ports from minimum to standard request or client request.
- 5. Recorded the test result as shown in following table.

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Test conditions:

Impulse Frequency: 5kHz
Tr/Th: 5/50ns
Burst Duration: 15ms
Burst Period: 300ms

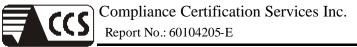
Inject Line	Voltage kV	Inject Method	Result (Pass/Fail)
L	± 1	Direct	Pass
N	± 1	Direct	Pass
PE	± 1	Direct	Pass
L+N	± 1	Direct	Pass
L + PE	± 1	Direct	Pass
N + PE	± 1	Direct	Pass
L + N + PE	± 1	Direct	Pass
RJ45	±0.5	Clamp	Pass

Performance & Result:

	Criterion A:	The apparatus continues to operate as intended. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance.		
	Criterion B:	The apparatus continues to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.		
	Criterion C:	Temporary loss of function is allowed, provided the functions self recoverable or can be restored by the operation of controls.		
Oł	Observation: No function degraded during the tests.			

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13 SURGE IMMUNITY TEST

Port : AC Power Port

Basic Standard : IEC/EN 61000-4-5

Requirements : ± 1 kV (Line to Line) for AC Power Port

± 2 kV (Line to Ground) for AC Power Port

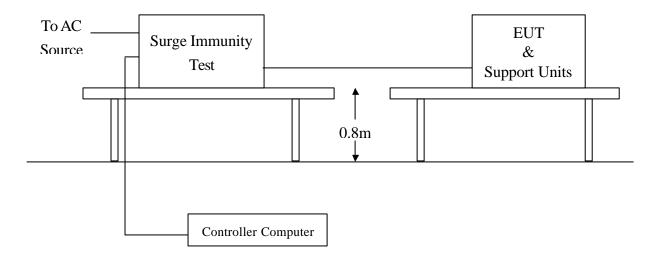
Performance Criteria: B (Standard Required)

Tested by : MATT HSU

: 19°C **Temperature** Humidity : 50%

Pressure : 1015mbar

Block Diagram of Test Setup:



Test Procedure:

- 1. The EUT and support units were located on a wooden table 0.8 m away from ground floor.
- 2. Injected test voltage to the EUT ports from minimum to standard request or client request.
- 3. Recorded the test result as shown in following table.

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Test conditions:

Voltage Waveform : 1.2/50 usCurrent Waveform : 8/20 us

Polarity : Positive/Negative Phase angle : 0°, 90°, 270°

Number of Test : 5

Coupling Line	Voltage (kV)	Polarity	Coupling Method	Result (Pass/Fail)
L1-L2	1	Positive	Capacitive	Pass
L1-PE	2	Positive	Capacitive	Pass
L2-PE	2	Positive	Capacitive	Pass
L1-L2	1	Negative	Capacitive	Pass
L1-PE	2	Negative	Capacitive	Pass
L2-PE	2	Negative	Capacitive	Pass

Performance & Result:

\boxtimes	Criterion A:	The apparatus continues to operate as intended. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance.
	Criterion B:	The apparatus continues to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.
	Criterion C:	Temporary loss of function is allowed, provided the functions self recoverable or can be restored by the operation of controls.
		Where normal functioning of LAN can't be achieved because of the impact of JT, no test be required.

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14 CONDUCTED DISTRBANCE/INDUCED RADIO-FREQUENCY FIELD IMMUNITY TEST

Port : AC Power Port and RJ45 Port

Basic Standard: IEC/EN 61000-4-6

Requirements : 3 V, with 80% AM. 1kHz Modulation.

Injection Method : CDN-M3 for AC Power Port

CDN-T4 for RJ45 Port

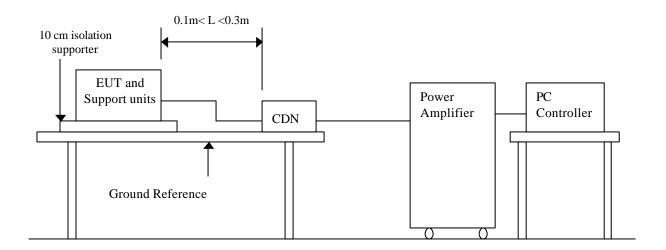
Performance Criterion: A (Standard Required)

Teste d by : MATT HSU

Temperature : 19°C **Humidity** : 50%

Pressure : 1015mbar

Block Diagram of Test Setup:



Test Procedure:

- 1. The EUT and support units were located at a ground reference plane with the interposition of a 0.1 m thickness insulating support and the CDN was located on GRP directly.
- 2. Set the testing parameters of CS test software as per IEC/EN 61000-4-6.
- 3. Recorded the test result in following table.

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Test conditions:

Frequency Range : 0.15MHz-80MHz Frequency Step : 1% of fundamental

Dwell Time : 3 sec

Range (MHz)	Field	Modulation	Result (Pass/Fail)
0.15-80	3V	Yes	Pass

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Performance & Result:

\boxtimes	Criterion A:	The apparatus continues to operate as intended. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance.			
	Criterion B:	: The apparatus continues to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.			
	Criterion C:	Temporary loss of function is allowed, provided the functions self recoverable or can be restored by the operation of controls.			
Ol	Observation: No function degraded during the tests.				

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15 POWER FREQUENCY MAGNETIC FIELD IMMUNITY TEST

Port : Enclosure

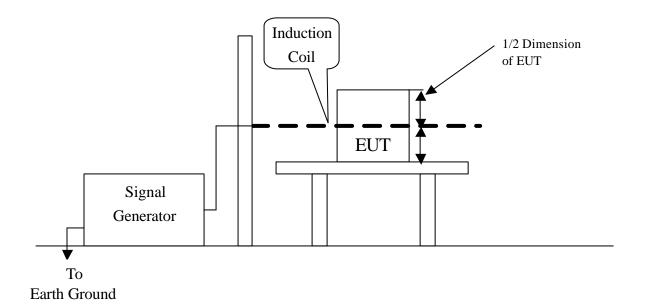
Basic Standard: IEC/EN 61000-4-8

Requirements : 1 A/m

Performance Criterion: A (Standard Required)

Tested by : N/A
Temperature : N/A
Humidity : N/A
Pressure : N/A

Block Diagram of Test Setup:



Test Procedure:

- 1. The EUT and support units were located on Ground Reference Plane with the interposition of a 0.1 m thickness insulation support.
- 2. Put the induction coil on horizontal direction. (X direction)
- 3. Recorded the test result as shown in following table.
- 4. Rotated the induction coil by 90° (Y direction) then repeat step 3.
- 5. Rotated the induction coil by 90 $^{\circ}$ (Z direction) then repeat step 3.

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Test conditions:

Field Strength: 1A/m Power Freq.: 50Hz Orientation: X, Y, Z

Orientation	Field	Result (Pass/Fail)	Remark

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Performance &	& Result:
Criterion A:	The apparatus continues to operate as intended. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance.
Criterion B:	The apparatus continues to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.
Criterion C:	Temporary loss of function is allowed, provided the functions self recoverable or can be restored by the operation of controls.
	☐ PASS ☐ FAIL
Observation:	The EUT is not containing any component that is susceptible to a 50 Hz or 60 Hz magnetic failed. Therefore, this requirement is not applicable to the EUT.

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16 VOLTAGE DIPS / SHORT INTERRUPTIONS

Port : AC Power Port

Basic Standard: IEC/EN 61000-4-11

Requirement: PHASE ANGLE 0, 45, 90, 135, 180, 225, 270, 315 degrees

Test Interval : Min. 10 sec. **Tested by** : MATT HSU

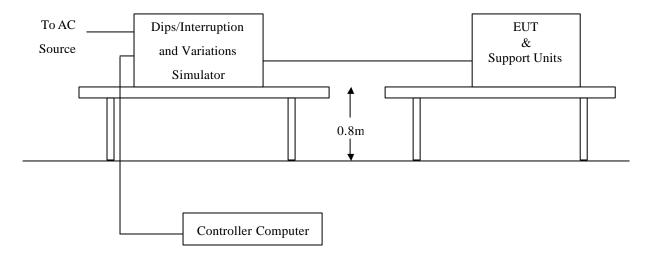
Temperature : 19°C **Humidity** : 50%

Pressure: 1015mbar

Voltage	Test Level % U _T	Reduction (%)	Duration (periods)	Performance Criterion
Dips	<5	>95	0.5	В
	70	30	25	C

Voltage Interruptions	Test Level % U _T	Reduction (%)	Duration (periods)	Performance Criterion
Interruptions	<5	>95	250	С

Block Diagram of Test Setup:



Test Procedure:

- 1. The EUT and support units were located on a wooden table, 0.8 m away from ground floor.
- 2. Set the parameter of tests and then Performed the test software of test simulator.
- 3. Changed Condition to occur at 0 degree crossover point of the voltage waveform.
- 4. Recorded the test result in test record form.

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Test conditions:

The duration with a sequence of three dips/interruptions with interval of 10 sec. minimum (Between each test event)

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Voltage Dips:

Test Level % U _T	Reduction (%)	Duration (periods)	Observation	Meet Performance Criterion
0	100	0.5	Normal	A
70	30	25	Normal	A

Voltage Interruptions:

Test Level % U _T	Reduction (%)	Duration (periods)	Observation	Meet Performance Criterion
0	100	250	EUT shut down, but EUT can be auto recovered after it restart.	С

Note: "Normal" means no any functions degrade during and after the test.

Performance & Result:

Criterion A: The apparatus continues to operate as intended. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance.

Criterion B: The apparatus continues to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.

Criterion C: Temporary loss of function is allowed, provided the functions self recoverable or can be restored by the operation of controls.

	☐ FAIL			
Observation: No function degraded during the tests.				

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APPENDIX I - PHOTOGRAPHS OF TEST SETUP

LINE CONDUCTED EMISSION TEST (EN 55022)





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COMMON MODE CONDUCTED EMISSION TEST





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RADIATED EMISSION TEST





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POWER HARMONIC & VOLTAGE FLUCTUATION / FLICKER TEST



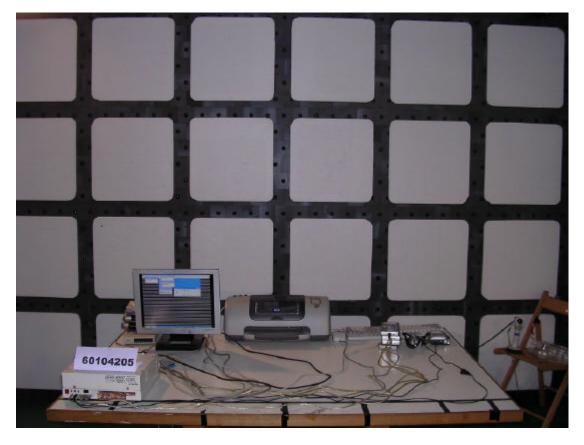


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ELECTROSTATIC DISCHARGE TEST



RADIATED ELECTROMAGNETIC FIELD TEST



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FAST TRANSIENTS/BURST TEST



(IEC 61000-4-4 FOR I/O)



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SURGE IMMUNITY TEST



CONDUCTED DISTURBANCE, INDUCED BY RADIO-FREQUENCY FIELDS TEST



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(IEC 61000-4-6 FOR I/O)



VOLTAGE DIPS / INTERRUPTION TEST

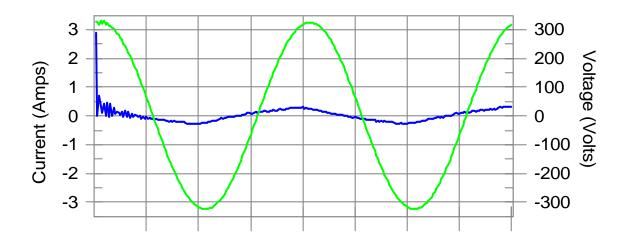


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APPENDIX II – TEST RESULT OF EN 61000-3/2-3

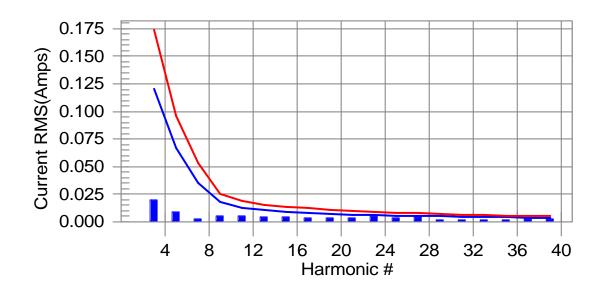
Test Result: Pass Source qualification: Normal

Current & voltage waveforms



Harmonics and Class D limit line

European Limits



Test result: Pass Worst harmonic was #23 with 62.67 % of the limit.

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Test Result: Pass Source qualification: Normal

Highest parameter values during test:

V_RMS (Volts): 230.11

 I_Peak (Amps):
 2.904
 I_RMS (Amps):
 0.196

 I_Fund (Amps):
 0.206
 Crest Factor:
 14.802

 Power (Watts):
 39
 Power Factor:
 0.885

Harm#	Harms(avg)	100%Limit	%of Limit	Harms(max)	150%Limit	%of Limit	Status
2	0.000						
3	0.019	0.120	15.9	0.020	0.174	11.56	Pass
4	0.000				-		
5	0.008	0.067	12.5	0.009	0.096	9.35	Pass
6	0.000						
7	0.002	0.035	4.6	0.002	0.053	3.95	Pass
8	0.000						
9	0.005	0.018	26.3	0.005	0.026	19.06	Pass
10	0.000						
11	0.004	0.012	32.5	0.005	0.018	27.06	Pass
12	0.000						
13	0.004	0.011	34.8	0.004	0.016	27.43	Pass
14	0.000						
15	0.003	0.009	36.2	0.004	0.013	29.56	Pass
16	0.000						
17	0.003	0.008	37.0	0.004	0.012	30.08	Pass
18	0.000						_
19	0.003	0.007	43.9	0.004	0.010	36.61	Pass
20	0.000						_
21	0.003	0.006	46.3	0.004	0.009	38.10	Pass
22	0.000	0.000	77.0	0.005	0.000	20.07	
23	0.004	0.006	77.3	0.005	0.009	62.67	Pass
24	0.000	0.005	20.0	0.000	0.000	05.70	D
25	0.002	0.005	39.3	0.003	0.008	35.72	Pass
26	0.000	0.005	07.0	0.004	0.000	50.00	D
27	0.003	0.005	67.9	0.004	0.008	50.20	Pass
28 29	0.000 0.002	0.005	32.4	0.002	0.007	27.12	Pass
30	0.002	0.003	32.4	0.002	0.007	27.12	Fa55
30 31	0.001	0.004	15.0	0.001	0.006	19.62	Pass
32	0.000	0.004	13.0	0.001	0.000	19.02	газэ
33	0.001	0.004	28.4	0.002	0.006	31.66	Pass
34	0.000	0.004	20.4	0.002	0.000	31.00	1 433
35	0.001	0.004	35.2	0.002	0.006	31.49	Pass
36	0.000	0.004	00.2	0.002	0.000	31.43	
37	0.001	0.004	37.4	0.002	0.005	39.21	Pass
38	0.000	0.004	J	0.002	0.000	30.21	
39	0.002	0.004	61.3	0.002	0.005	48.95	Pass
40	0.000		· · · · ·		5.556		

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Test Result: Pass Source qualification: Normal

Highest parameter values during test:

Voltage (Vrms): 230.11

 I_Peak (Amps):
 2.904
 I_RMS (Amps):
 0.196

 I_Fund (Amps):
 0.206
 Crest Factor:
 14.802

 Power (Watts):
 39
 Power Factor:
 0.885

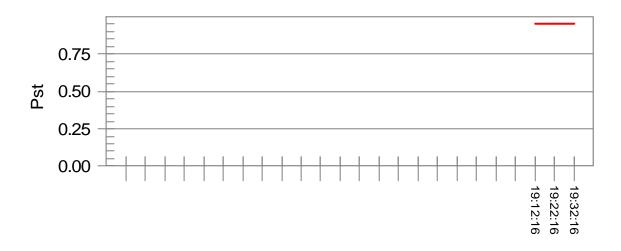
Harm#	Harmonics V-rms	Limit V-rms	% of Limit	Status
2	0.136	0.459	29.67	ОК
3	0.379	2.068	18.31	ОК
4	0.054	0.459	11.78	OK
5	0.043	0.920	4.73	ок
6	0.096	0.460	20.78	OK
7	0.037	0.689	5.33	OK
8	0.039	0.460	8.44	OK
9	0.057	0.460	12.36	OK
10	0.034	0.460	7.42	OK
11	0.089	0.230	38.52	OK
12	0.028	0.230	12.35	OK
13	0.037	0.230	16.24	OK
14	0.021	0.230	9.18	OK
15	0.028	0.230	12.05	OK
16	0.020	0.230	8.54	OK
17	0.016	0.230	7.18	OK
18	0.022	0.230	9.64	OK
19	0.015	0.230	6.54	OK
20	0.021	0.230	9.18	OK
21	0.024	0.230	10.35	OK
22	0.027	0.230	11.69	OK
23	0.075	0.230	32.64	OK
24	0.030	0.230	12.93	OK
25	0.064	0.230	27.81	OK
26	0.036	0.230	15.47	OK
27	0.047	0.230	20.29	OK
28	0.042	0.230	18.27	OK
29	0.024	0.230	10.65	OK
30	0.055	0.230	24.10	OK
31	0.018	0.230	7.99	OK
32	0.032	0.230	14.03	OK
33	0.021	0.230	9.35	OK
34	0.012	0.230	5.20	OK
35	0.025	0.230	10.78	OK
36	0.010	0.230	4.50	OK
37	0.023	0.230	10.10	OK
38	0.009	0.230	4.00	OK
39	0.010	0.230	4.22	OK
40	0.012	0.230	5.14	OK

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Test Result: Pass Status: Test Completed

Pst_i and limit line

European Limits



Time is too short for Plt plot

Parameter values recorded during the test:

Vrms at the end of test (Volt):	229.48			
Highest dt (%):	0.00	Test limit (%):	3.14	Pass
Time(mS) > dt:	0.0	Test limit (mS):	500.0	Pass
Highest dc (%):	0.00	Test limit (%):	3.14	Pass
Highest dmax (%):	0.00	Test limit (%):	3.80	Pass
Highest Pst (10 min. period):	0.001	Test limit:	0.950	Pass
Highest Plt (2 hr. period):	0.001	Test limit:	0.617	Pass

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